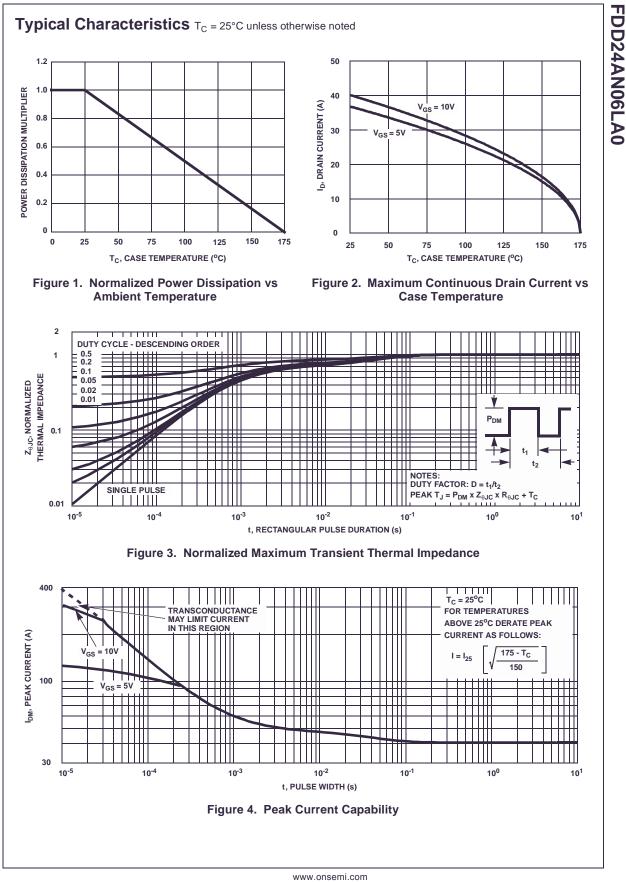
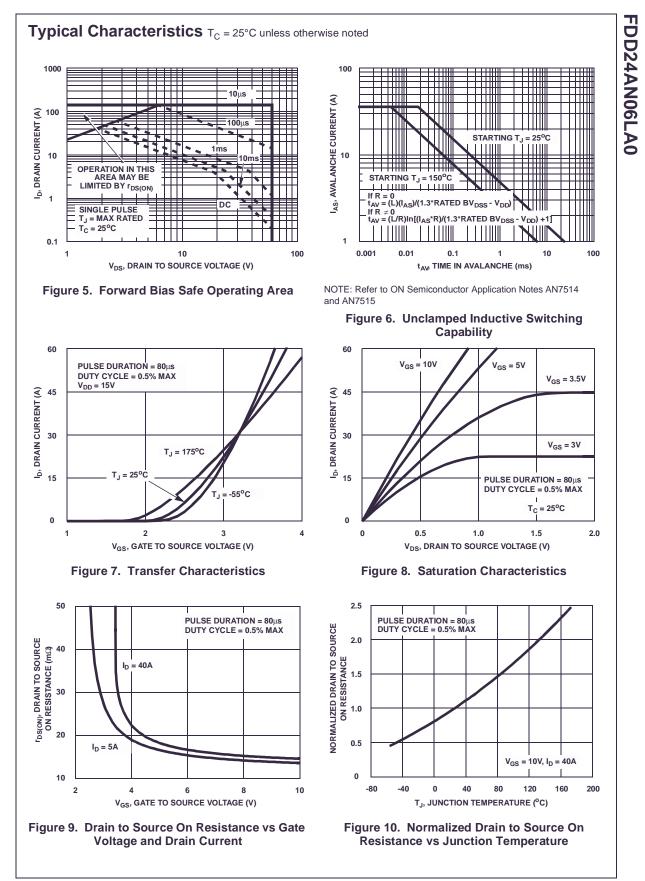
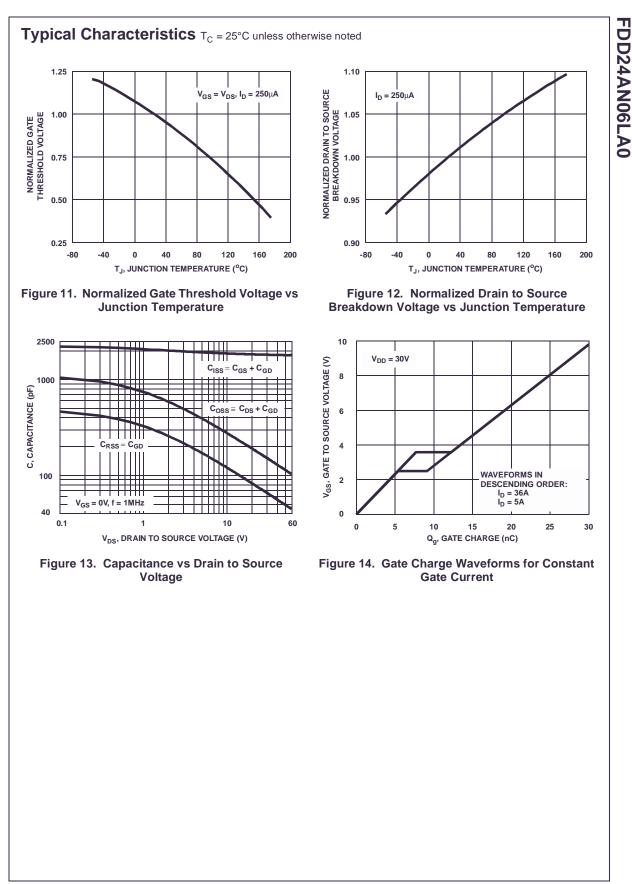
Symbol Off Chara	N06LA0	Device	Package	Reel Size	Tape Width		Quantity	
Symbol Off Chara		FDD24AN06LA0 TO-252AA 3		330mm	16mm		2500 units	
Off Chara	al Chara	acteristics T <sub>c</sub> = 25°C	unless otherwis	e noted				
-	Symbol Parameter		Test (	Test Conditions		Тур	Max	Units
D	acteristics	5						
B <sub>VDSS</sub>	Drain to Source Breakdown Voltage		$I_{D} = 250 \mu A, V_{GS} = 0 V$		60	-	-	V
I <sub>DSS</sub>	Zero Gate	e Voltage Drain Current	$V_{DS} = 50V$		-	-	1	μA
		-	$V_{GS} = 0V$	$T_{\rm C} = 150^{\rm o}{\rm C}$		250		
I <sub>GSS</sub>	Gate to Source Leakage Current		$V_{GS} = \pm 20V$		-	-	±100	nA
On Chara	acteristics	6						
V <sub>GS(TH)</sub>	Gate to Source Threshold Voltage		$V_{GS} = V_{DS}, I_D = 250 \mu A$		1	-	2	V
				$I_{\rm D} = 40$ A, $V_{\rm GS} = 10$ V		0.016	0.019	
	Drain to Source On Resistance		$I_{\rm D} = 36 \rm A, V_{\rm GS}$	$I_D = 36A, V_{GS} = 5V$ $I_D = 36A, V_{GS} = 5V,$		0.020	0.024	Ω
r <sub>DS(ON)</sub>						0.047	0.056	
			T <sub>J</sub> = 175°C					0.000
Dynamic	Characte	eristics						
C <sub>ISS</sub>	Input Cap	acitance			-	1850	-	pF
C <sub>OSS</sub>	Output Ca		$V_{DS} = 25V, V$	<sub>GS</sub> = 0V,	-	180	-	pF
C <sub>RSS</sub>	Reverse T	ransfer Capacitance	f = 1MHz		-	75	-	pF
Q <sub>g(TOT)</sub>	Total Gate	Charge at 5V	V <sub>GS</sub> = 0V to §	5V		16	21	nC
Q <sub>g(TH)</sub>	Threshold	Gate Charge		$V_{DD} = 30V$	-	1.8	2.4	nC
Q <sub>gs</sub>	Gate to So	ource Gate Charge		I <sub>D</sub> = 36A	-	6.3	-	nC
Q <sub>gs2</sub>	Gate Charge Threshold to Plateau Gate to Drain "Miller" Charge		$I_g = 1.0 \text{mA}$		-	4.5	-	nC
Q <sub>gd</sub>						5.0	-	nC
Switching	g Charact	teristics (V <sub>GS</sub> = 5V)						
t <sub>ON</sub>	Turn-On T	Turn-On Time		_		-	195	ns
t <sub>d(ON)</sub>	Turn-On Delay Time   Rise Time   Turn-Off Delay Time   Fall Time   Turn-Off Time					12	-	ns
t <sub>r</sub>			V <sub>DD</sub> = 30V, I <sub>D</sub> = 36A		-	118	-	ns
t <sub>d(OFF)</sub>			$V_{GS} = 5V, R_{G}$	$V_{GS} = 5V, R_{GS} = 9.1\Omega$		26	-	ns
t <sub>f</sub>			_		-	41	-	ns
t <sub>OFF</sub>				-		-	101	ns
	urce Dioc	le Characteristics						
	Course to Drain Diado Maltana		I <sub>SD</sub> = 36A		-	-	1.25	V
V.		Source to Drain Diode Voltage		I <sub>SD</sub> = 18A		-	1.0	V
V <sub>SD</sub>	Povorco E	Recovery Time	$I_{SD}$ = 36A, $dI_{SD}/dt$ = 100A/µs		-	-	34	ns
V <sub>SD</sub> t <sub>rr</sub> Q <sub>RR</sub>		Recovered Charge	1 004 11	<sub>SD</sub> /dt = 100A/µs	-	-	30	nC

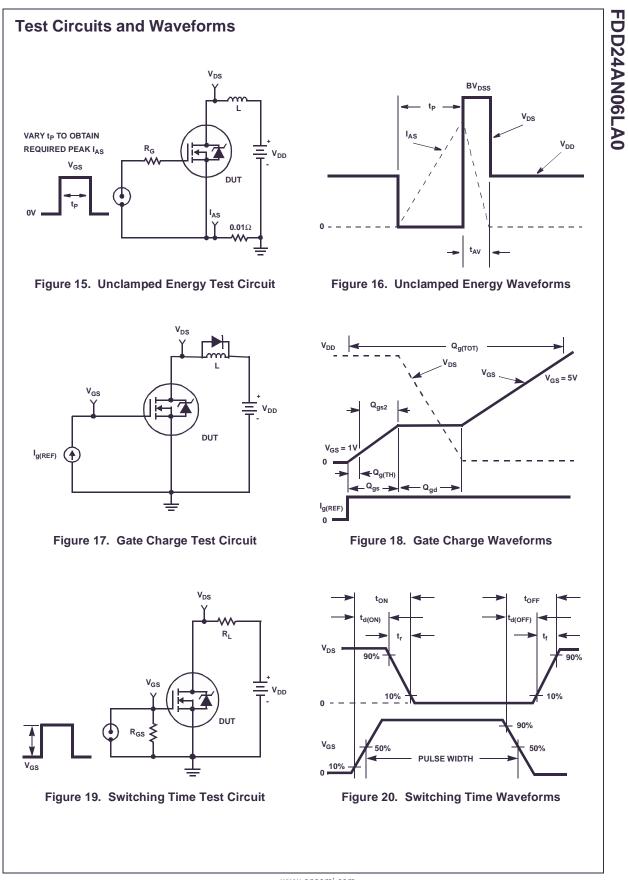
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3







## Thermal Resistance vs. Mounting Pad Area

The maximum rated junction temperature,  $T_{JM}$ , and the thermal resistance of the heat dissipating path determines the maximum allowable device power dissipation,  $P_{DM}$ , in an application. Therefore the application's ambient temperature,  $T_A$  (°C), and thermal resistance  $R_{\theta JA}$  (°C/W) must be reviewed to ensure that  $T_{JM}$  is never exceeded. Equation 1 mathematically represents the relationship and serves as the basis for establishing the rating of the part.

$$P_{DM} = \frac{(T_{JM} - T_A)}{R_{\theta JA}}$$
(EQ. 1)

In using surface mount devices such as the TO-252 package, the environment in which it is applied will have a significant influence on the part's current and maximum power dissipation ratings. Precise determination of  $\mathsf{P}_{\mathsf{DM}}$  is complex and influenced by many factors:

- Mounting pad area onto which the device is attached and whether there is copper on one side or both sides of the board.
- 2. The number of copper layers and the thickness of the board.
- 3. The use of external heat sinks.
- 4. The use of thermal vias.
- 5. Air flow and board orientation.
- 6. For non steady state applications, the pulse width, the duty cycle and the transient thermal response of the part, the board and the environment they are in.

ON Semiconductor provides thermal information to assist the designer's preliminary application evaluation. Figure 21

defines the R<sub>0JA</sub> for the device as a function of the top copper (component side) area. This is for a horizontally positioned FR-4 board with 1oz copper after 1000 seconds of steady state power with no air flow. This graph provides the necessary information for calculation of the steady state junction temperature or power dissipation. Pulse applications can be evaluated using the ON Semiconductor device Spice thermal model or manually utilizing the normalized maximum transient thermal impedance curve.

Thermal resistances corresponding to other copper areas can be obtained from Figure 21 or by calculation using Equation 2 or 3. Equation 2 is used for copper area defined in inches square and equation 3 is for area in centimeters square. The area, in square inches or square centimeters is the top copper area including the gate and source pads.

$$R_{\theta JA} = 33.32 + \frac{23.84}{(0.268 + Area)}$$
 (EQ. 2)

Area in Inches Squared

$$R_{\theta JA} = 33.32 + \frac{154}{(1.73 + Area)}$$
(EQ. 3)

Area in Centimeters Squared

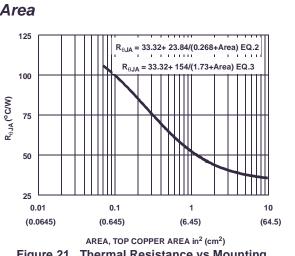
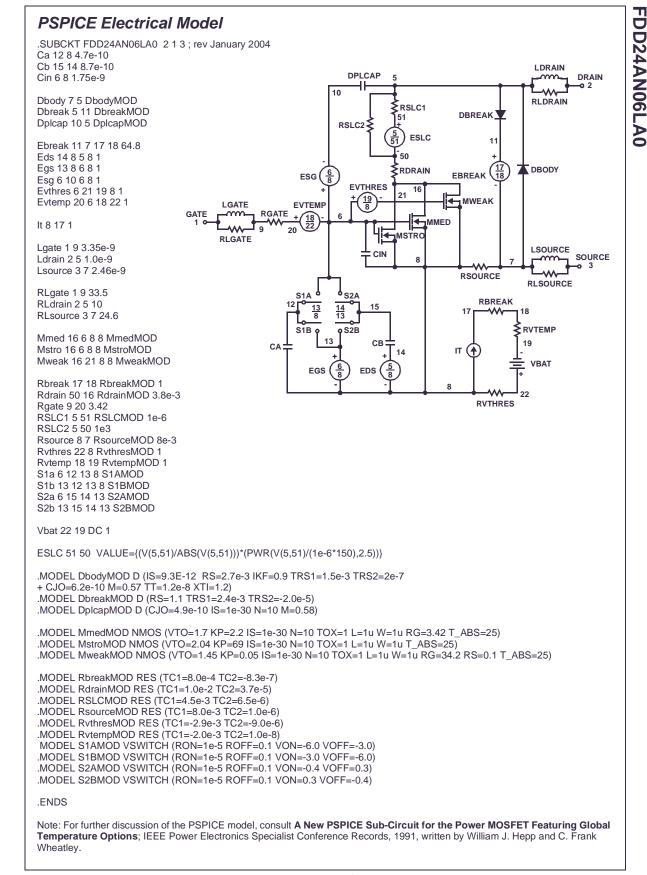
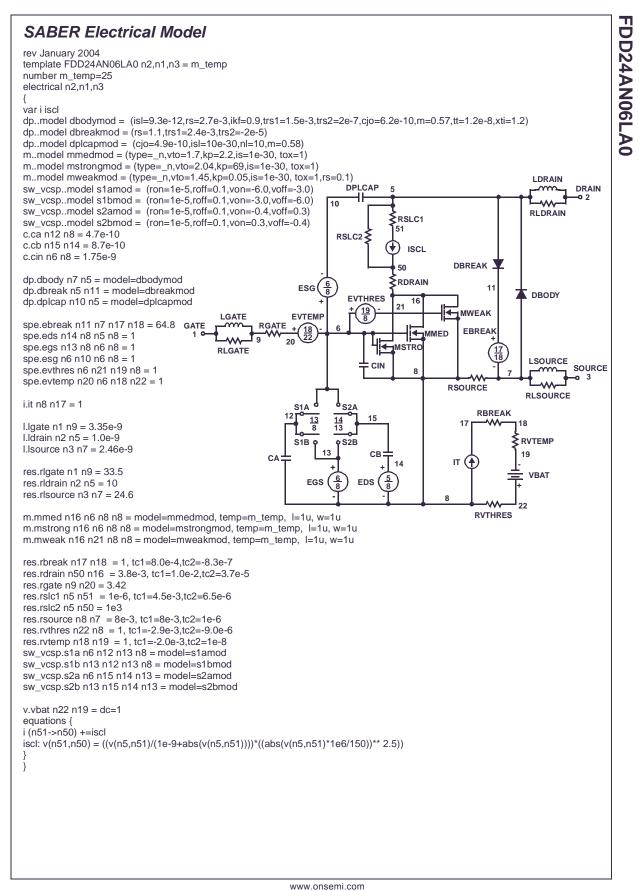


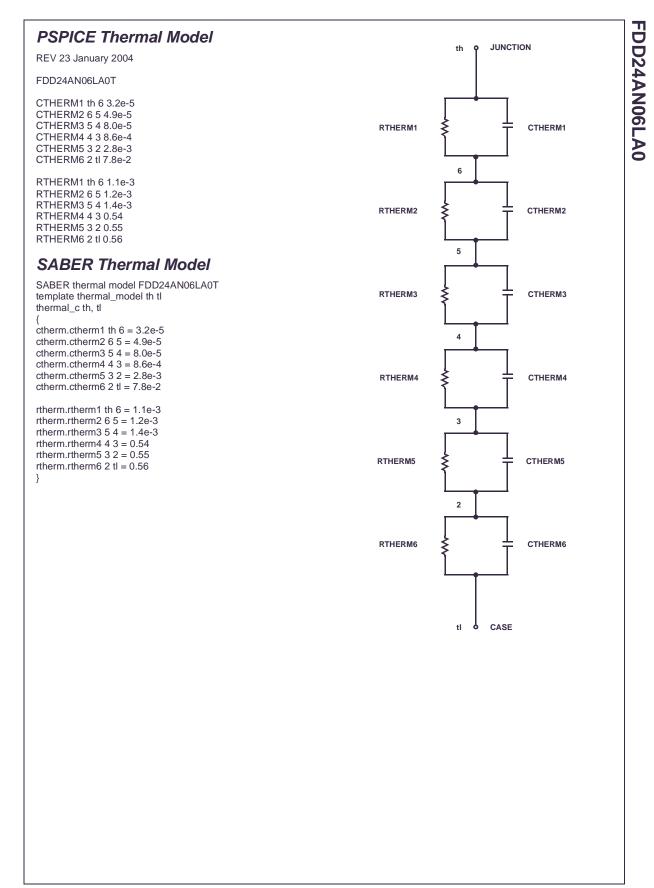
Figure 21. Thermal Resistance vs Mounting Pad Area

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